

SN74S1051

12-BIT SCHOTTKY BARRIER DIODE BUS-TERMINATION ARRAY

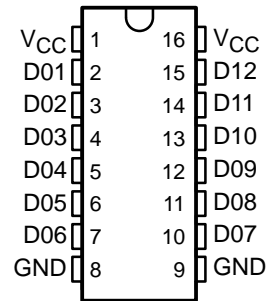
SDLS018B – SEPTEMBER 1990 – REVISED MARCH 2003

- Designed to Reduce Reflection Noise
- Repetitive Peak Forward Current to 200 mA
- 12-Bit Array Structure Suited for Bus-Oriented Systems

description/ordering information

This Schottky barrier diode bus-termination array is designed to reduce reflection noise on memory bus lines. This device consists of a 12-bit high-speed Schottky diode array suitable for clamping to V_{CC} and/or GND.

D, N, NS, OR PW PACKAGE (TOP VIEW)

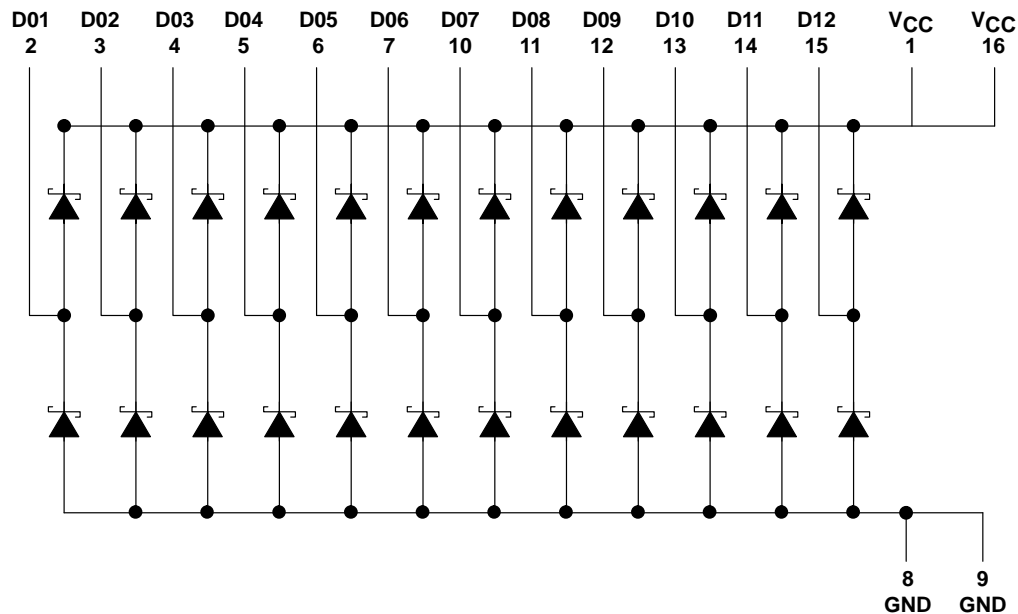


ORDERING INFORMATION

T_A	PACKAGE†		ORDERABLE PART NUMBER	TOP-SIDE MARKING
0°C to 70°C	PDIP – N	Tube	SN74S1051N	SN74S1051N
	SOIC – D	Tube	SN74S1051D	S1051
		Tape and reel	SN74S1051DR	
	SOP – NS	Tape and reel	SN74S1051NSR	74S1051
	TSSOP – PW	Tape and reel	SN74S1051PWR	S1051

† Package drawings, standard packing quantities, thermal data, symbolization, and PCB design guidelines are available at www.ti.com/sc/package.

schematic diagrams



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PRODUCTION DATA information is current as of publication date. Products conform to specifications per the terms of Texas Instruments standard warranty. Production processing does not necessarily include testing of all parameters.

**TEXAS
INSTRUMENTS**

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absolute maximum ratings over operating free-air temperature range (unless otherwise noted)[†]

Steady-state reverse voltage, V_R	7 V
Continuous forward current, I_F : Any D terminal from GND or to V_{CC}	50 mA
Total through all GND or V_{CC} terminals	170 mA
Repetitive peak forward current [‡] , I_{FRM} : Any D terminal from GND or V_{CC}	200 mA
Total through all GND or V_{CC} terminals	1 A
Package thermal impedance, θ_{JA} (see Note 1): D package	73°C/W
N package	67°C/W
NS package	64°C/W
PW package	108°C/W
Operating free-air temperature range	0°C to 70°C
Storage temperature range, T_{stg}	–65°C to 150°C

[†] Stresses beyond those listed under “absolute maximum ratings” may cause permanent damage to the device. These are stress ratings only, and functional operation of the device at these or any other conditions beyond those indicated under “recommended operating conditions” is not implied. Exposure to absolute-maximum-rated conditions for extended periods may affect device reliability.

[‡] These values apply for $t_W \leq 100 \mu s$, duty cycle $\leq 20\%$.

NOTE 1: The package thermal impedance is calculated in accordance with JESD 51-7.

electrical characteristics over recommended operating free-air temperature range (unless otherwise noted)

single-diode operation (see Note 2)

PARAMETER	TEST CONDITIONS	MIN	TYP [§]	MAX	UNIT
V_F Static forward voltage	To V_{CC}	$I_F = 18 \text{ mA}$	0.85	1.05	V
			1.05	1.3	
	From GND	$I_F = 18 \text{ mA}$	0.75	0.95	
			0.95	1.2	
V_{FM} Peak forward voltage		$I_F = 200 \text{ mA}$	1.45		V
I_R Static reverse current	To V_{CC}	$V_R = 7 \text{ V}$		5	μA
	From GND			5	
C_t Total capacitance	$V_R = 0 \text{ V}$, $f = 1 \text{ MHz}$		8	16	pF
	$V_R = 2 \text{ V}$, $f = 1 \text{ MHz}$		4	8	

[§] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

NOTE 2: Test conditions and limits apply separately to each of the diodes. The diodes not under test are open-circuited during the measurement of these characteristics.

multiple-diode operation

PARAMETER	TEST CONDITIONS	MIN	TYP [§]	MAX	UNIT
I_X Internal crosstalk current	Total I_F current = 1 A, See Note 3		0.8	2	mA
	Total I_F current = 198 mA, See Note 3		0.02	0.2	

[§] All typical values are at $V_{CC} = 5 \text{ V}$, $T_A = 25^\circ\text{C}$.

NOTE 3: I_X is measured under the following conditions with one diode static, all others switching:

Switching diodes: $t_W = 100 \mu s$, duty cycle = 20%

Static diode: $V_R = 5 \text{ V}$

The static diode input current is the internal crosstalk current, I_X .

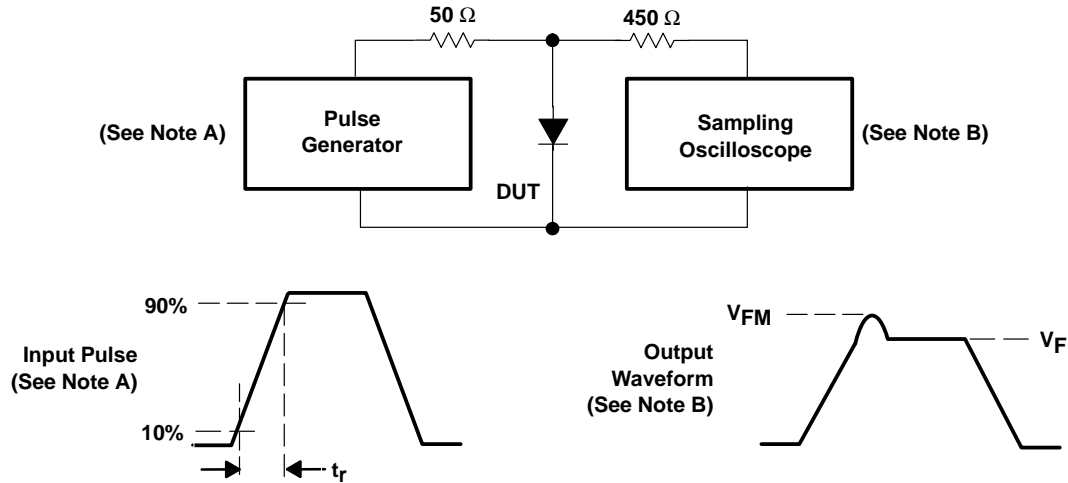
switching characteristics over recommended operating free-air temperature range (unless otherwise noted) (see Figures 1 and 2)

PARAMETER	TEST CONDITIONS	MIN	TYP	MAX	UNIT
t_{rr} Reverse recovery time	$I_F = 10 \text{ mA}$, $I_{RM(REC)} = 10 \text{ mA}$, $I_{R(REC)} = 1 \text{ mA}$, $R_L = 100 \Omega$		8	16	ns



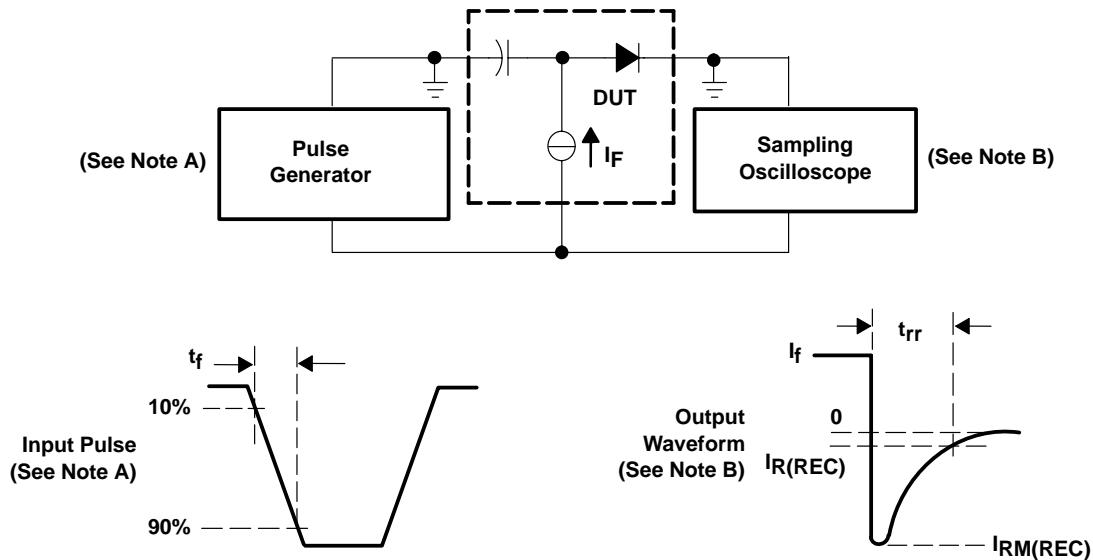
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PARAMETER MEASUREMENT INFORMATION



- NOTES: A. The input pulse is supplied by a pulse generator having the following characteristics: $t_r = 20$ ns, $Z_O = 50$ Ω, freq = 500 Hz, duty cycle = 1%.
B. The output waveform is monitored by an oscilloscope having the following characteristics: $t_r \leq 350$ ps, $R_i = 50$ Ω, $C_i \leq 5$ pF.

Figure 1. Forward Recovery Voltage



- NOTES: A. The input pulse is supplied by a pulse generator having the following characteristics: $t_f = 0.5$ ns, $Z_O = 50$ Ω, $t_w \geq 50$ ns, duty cycle = 1%.
B. The output waveform is monitored by an oscilloscope having the following characteristics: $t_r \leq 350$ ps, $R_i = 50$ Ω, $C_i \leq 5$ pF.

Figure 2. Reverse Recovery Time

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APPLICATION INFORMATION

Large negative transients at the inputs of memory devices (DRAMs, SRAMs, EPROMs, etc.) or on the CLOCK lines of many clocked devices can result in improper operation of the devices. The SN74S1051 diode termination array helps suppress negative transients caused by transmission-line reflections, crosstalk, and switching noise.

Diode terminations have several advantages when compared to resistor termination schemes. Split-resistor or Thevenin-equivalent termination can cause a substantial increase in power consumption. The use of a single resistor to ground to terminate a line usually results in degradation of the output high level, resulting in reduced noise immunity. Series damping resistors placed on the outputs of the driver reduce negative transients, but they also can increase propagation delays down the line because a series resistor reduces the output drive capability of the driving device. Diode terminations have none of these drawbacks.

The operation of the diode arrays in reducing negative transients is explained in the following figures. The diode conducts current when the voltage reaches a negative value large enough for the diode to turn on. Suppression of negative transients is tracked by the current-voltage characteristic curve for that diode. Typical current-versus-voltage curves for the SN74S1051 are shown in Figures 3 and 4.

To illustrate how the diode arrays act to reduce negative transients at the end of a transmission line, the test setup in Figure 5 was evaluated. The resulting waveforms with and without the diode are shown in Figure 6.

The maximum effectiveness of the diode arrays in suppressing negative transients occurs when the diode arrays are placed at the end of a line and/or the end of a long stub branching off a main transmission line. The diodes can also reduce the negative transients that occur due to discontinuities in the middle of a line. An example of this is a slot in a backplane that is provided for an add-on card.

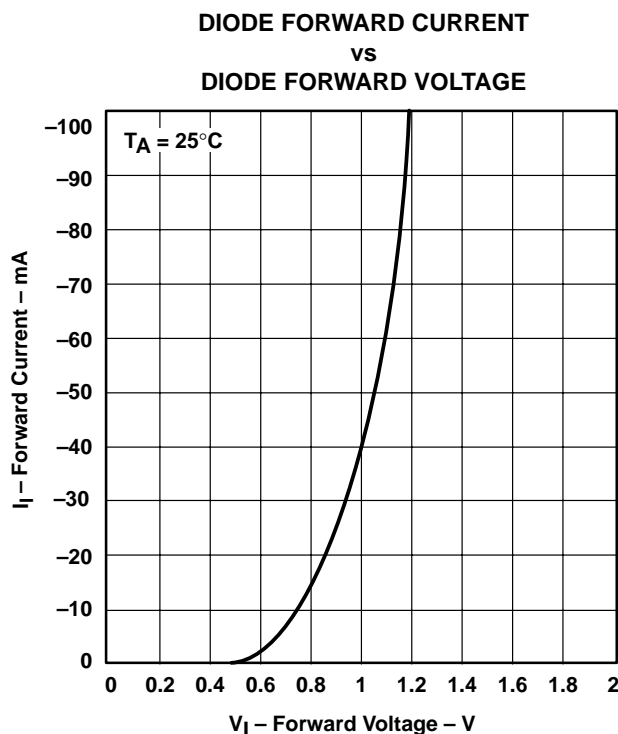


Figure 3. Typical Input Current vs Input Voltage
(Lower Diode)

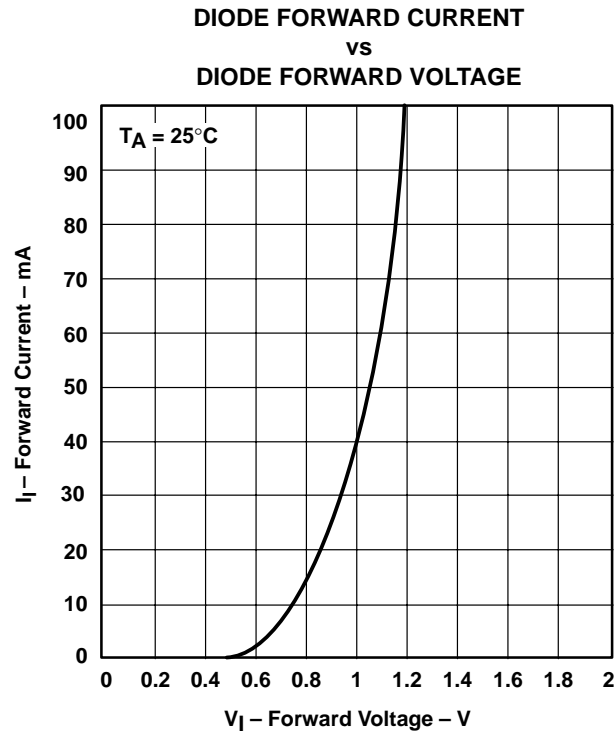


Figure 4. Typical Input Current vs Input Voltage
(Upper Diode)

$Z_0 = 50 \, \Omega$
Length = 36 in.

The diagram shows a horizontal transmission line represented by a cylinder. To the left of the cylinder, a vertical line segment is shown, representing the input of the transmission line. To the right of the cylinder, the line continues and then splits into two parallel vertical branches. The left branch contains a switch (represented by two small circles connected by a diagonal line) in series with a load (represented by a triangle pointing upwards). The right branch is a simple vertical line segment. Both branches terminate in ground symbols (represented by three horizontal lines of decreasing width).

[illegible]

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